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SEMoscope

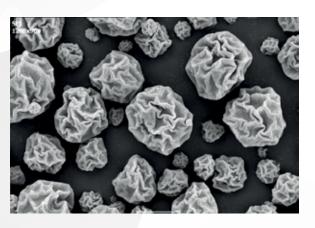
## INTRODUCTION

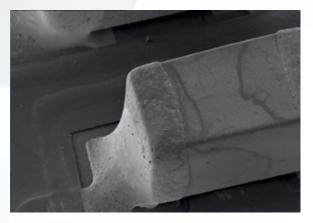
We believe that every laboratory working in the field of nanotechnology needs an SEM, therefore we would like to introduce to you our IEM series of SEM. In short space of time, our device that is the size of an old computer will prove its effectiveness, and will help you achieve a significant step in your research. The advantage of the images obtained by SEM lies in the high magnification factor: you will be able to magnify an image by up to 150,000 times which will enable you to conduct analyses up to a nanoscale using different detectors such as BSE, SE and EDS (X-ray detector). The SEM can be used in many areas and there is no restriction to analyses on samples. Another important factor to purchase our SEM is to avoid waiting the annoying time for obtaining images from a nearby facility, instead of that your images can be available in an unbelievable short time. Our SEMs are easy to operate and your employees or students can use it without any waste of time in a special training.

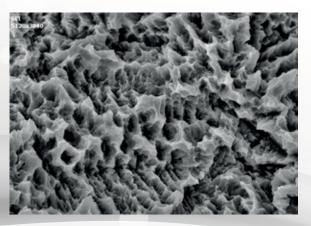
Inovenso Team

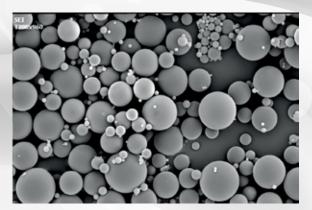












## IEM 10



- Magnification Up To x 100,000
- F Auto Stage: X, Y, T Axis
- F Click & Move Stage Control
- Auto Function: Filament Memory, Focus, Contrast, Brightness
- Figh Definition Image : 5120 X 3840 Pixel



#### Specifications

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S

Magnification	x20 ~ x100,000 (Efficient: ~x50,000)		
Acc Voltage	1 ~ 30 kV (1kV increments)		
electron Gun	Tungsten Filament (W)		
Detector	SE Detector		
itage	Auto Stage (X: 35mm,Y: 35mm,T: 0 to 45°)		
	Manual Stage (Z: 5 to 50mm)		

Image Shift Operating System Dimensions (mm) Dimensions (inch) Weight X, Y, R(Rotation) Microsoft Windows 7 400(W) x 600(L) x 550(H) 15,74(W) x 23,62(L) x 21,65(H) 85(kgs) - 187 (lbs)



Stage Position Users can easily locate the sample on the stage



#### **Click & Move**

By applying the auto stage, stage is controlled simply with a mouse click

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#### **Auto Focus & Fine Focus**

Auto focus function makes the operation easier and clearer images can be obtained even at the higher magnifications



#### **Filament Memory**

Filament's saturation point is automatically stored and activated

### IEM 10+



- Magnification Up To x 100,000
- F Auto Stage: X, Y, T Axis
- F Click & Move Stage Control
- FAuto Function: Filament Memory, Focus, Contrast,
- 🗲 Brightness
- F High Definition Image: 5120 X 3840 Pixel
- F Thermo EDS Detector: 133 eV at Mn, B(5) ~ U(92)



#### **Specifications**

Magnification	x20 ~ x100,000 (Efficient: ~x50,000)		
Acc Voltage	1 ~ 30 kV (1kV increments)		
Electron Gun	Tungsten Filament (W)		
Detector	SE and EDS Detectors		
Stage	Auto Stage (X: 35mm,Y: 35mm,T: 0 to 45°)		
	Manual Stage (Z: 5 to 50mm)		

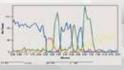
Image Shift Operating System Dimensions (mm) Dimensions (inch) Weight X, Y, R(Rotation) Microsoft Windows 7 400(W) x 600(L) x 550(H) 15,74(W) x 23,62(L) x 21,65(H) 95(kgs) - 210(lbs)

#### • • Rapid EDS Analysis

Point and shoot an alysis with NORAN System 7 software uses standardless quantitative analysis to enable rapid identification of various regions within a material.

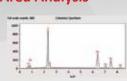
#### **Extracted Linescans**

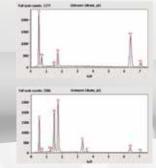




#### **Extracted Area Analysis**







	Point #1	Point #2	Point #3	
C-K	2.1	2.2	1.9	
O-K	58.3	61.8	61.3	
Mg-K	0.7			
Al-K	12.6	1.1	0.5	
Si-K	18.3	6.7	33.9	
K-K	4.2	0.1	0.1	
Co-K		0.1		
Fe-K	3.7	27.0	2.3	
Cu-K		0.9		
Weight percentages				

#### EDS Analysis with NORAN

System 7 Spectral Imaging

The UltraDry Compact EDS detector provides outstanding elemental mapping within few minutes. With Spectral Imaging, where a full EDS spectrum is stored at every pixel, samples can be analyzed after they have been removed from the microscope. NORAN System 7 tools provide several analytical methods for the best results.



## IEM 11



#### Specifications

Magnificationx20 ~ x100,000 (Efficient: ~x50,000)Acc Voltage1 ~ 30 kV (1kV increments)Electron GunTungsten Filament (W)DetectorSE DetectorStageAuto Stage (X: 35mmY: 35mm,T: 0 to 45°)<br/>Manual Stage (Z: 5 to 50mm)

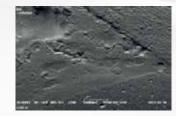
Image Shift Operating System Dimensions (mm) Dimensions (inch) Weight

F High Quality Images (5nm resolution)

X, Y, R(Rotation) Microsoft Windows 7 400(W) x 600(L) x 550(H) 15,74(W) x 23,62(L) x 21,65(H) 85(kgs) - 187(lbs)



SE: Composition Material: Alloy Metal



BSE: Topography Material: Alloy Metal



#### **Removable BSE Detector**

By applying 4-channel BSE detector, composition and topography functions are available. These functions are optional and can be opted out.

#### Low Voltage Analysis

Information on the morphology of a sample can be obtained with voltage ranging from 1 to 30kV.







ACC.Voltage : 5 kV / SE Image / Mag: x50,000

#### **Driving Mode**

Move "Left" Move "Down" Move "The second secon

2-axes stage motion, magnification, and focus can be easily motorized and controlled with a joystick.

**Combined Signaling** 

SE and BSE can be detected separately and together.



ACC.Voltage: 20kV Material: Alloy Metal

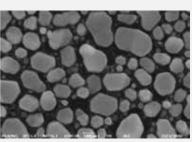


SE + BSE Image

**Highest Resolution** 

Provides high quality images (5nm

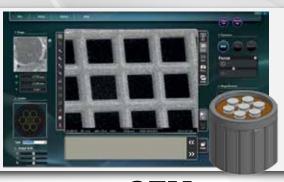
resolution, Max accelerating voltage: 30kV)



ACC. Voltage : 30kV / SE Image / Mag : x100,000

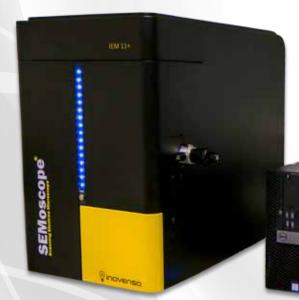
**Driving Mode** 

By loading seven samples simultaneously into a multi holder, samples can be easily located with the help of a mini map, sample area, and a live display.





## IEM 11+



- F High Quality Images (5nm resolution)
- Magnification Up To 150,000x
- Fasy Navigation with the "Navigation Mode"
- Precise Control with a Joystick and the "Driving Mode"
- F Combined SE and BSE Images
- F Low Energy Consumption
- F Intuitive User Interface
- Øxford:130eV at Mnk, C(6) ~ U(92) / EDAX:133eV at
- Mnk, Be(4) ~ U(92)



#### Specifications

Magnification	x20 ~ x150,000 (Efficient: ~x80,000)
Acc Voltage	1 ~ 30kV (1kV increments)
Electron Gun	Tungsten Filament (W)
Detector	SE and BSE Detectors
EDS	Oxford:130eV at Mnk, C(6) ~ U(92)
	EDAX:133eV at Mnk. Be(4) ~ U(92)

Image Shift	Auto Stage (X: 35mm, Y: 35mm, T: 0 to 45°) Manual Stage (Z: 5 to 50mm)		
Operating System	Microsoft Windows 7		
Dimensions (mm)	400(W) x 600(L) x 550(H)		
Dimensions (inch)	15,74(W) x 23,62(L) x 21,65(H)		
Weight	95(kgs)- 210(lbs)		

## **P**EDS

#### **Brand: Oxford**

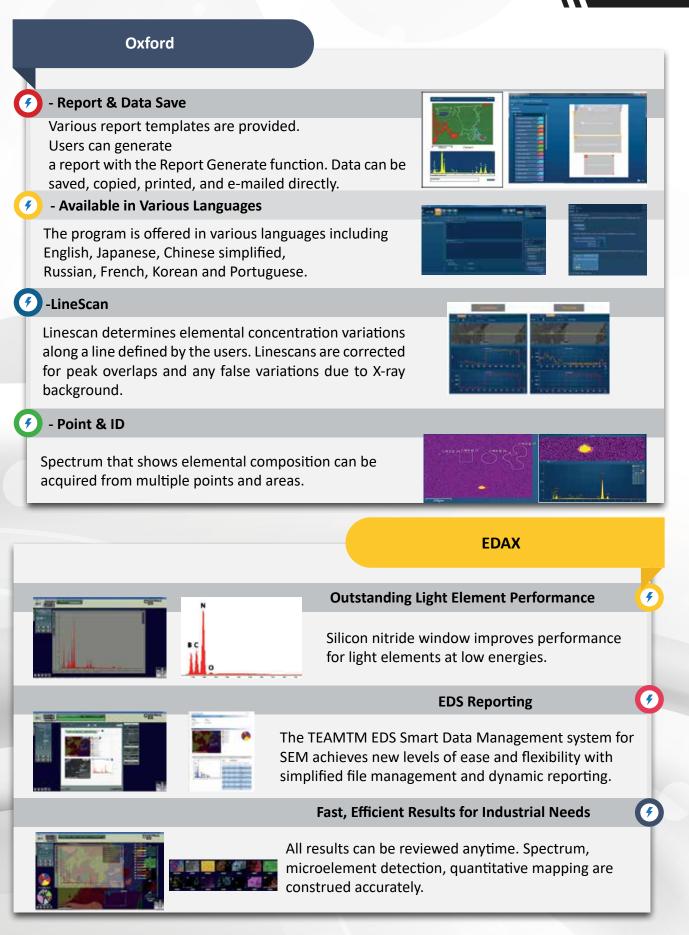
Tru-Q Analysis Engine: Accurate Result By Multi Algorithm Multilingual Operation Fast & Easy Analysis With Flow Chart Style Menu Diverse Element Analysis Functions: Point & ID, Line Scan, Mapping, Line Overlap & Background Correction

Quantitative Mapping (QuantLineScan, QuantMap)

#### Brand: EDAX

Highest Performance SDD Sensor Size: 30mm2 High Quality Light Element Analysis: Be(4) ~ Am(95) Diverse Element Analysis Functions: Point&ID Line Scan, Mapping

## IEM 11+





## Options

Target

**Power** 

**Target Size** 

Ionization Current

### **Ion Coater**

Simple Operation Compact Rotary Pump Suitable for Metal Targets (Au,Pt,Pd,Cr,Pt-Pd,Cu,Ni)

Au (Standard)

50mm[Dia]



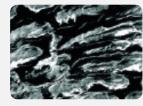
AC110-240V, 50 / 60Hz, 50W (Except Rotary Pump) Oxford:130eV at Mnk, C(6) ~ U(92)

EDAX:133eV at Mnk, Be(4) ~ U(92)

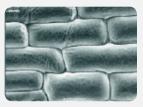
**Chamber Size Dimension (mm) Dimension (inch)** 

100(mm)[Dia] 420(W)x220(D)x230(H) 15,74(W)x 8,66(D)x 9,05(H)

- **Cool Stage**
- Suitable for Liquid or Biological Samples
- F Cool Stage Temperature: -25oC to 50oC
- F Temperature Resolution: ±0.1oC
- FTemperature Accuracy: ±1oC
- Specimen Holder Size: 18(mm)[Dia]- 0,70(inch) [Dia]
- F Vacuum Feed Through Flange



**Onion Skin** without Cool Stage

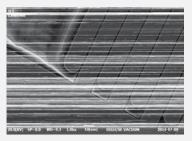


**Onion Skin** with Cool Stage

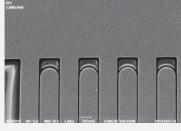


## Options

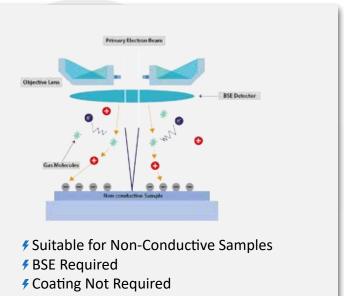
## Low Vacuum System



-High Vacuum SE Image



-Low Vacuum BSE Image

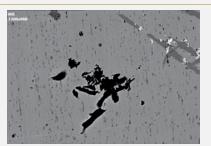


Vacuum Condition: 100pa to 1pa





- 4 Channel Solid State Type: 4 Segment
- F Excellent Composition and Topography
- Functions
- F Combined SE and BSE Images
- Synergistic Use of BSE Detector and LV Mode



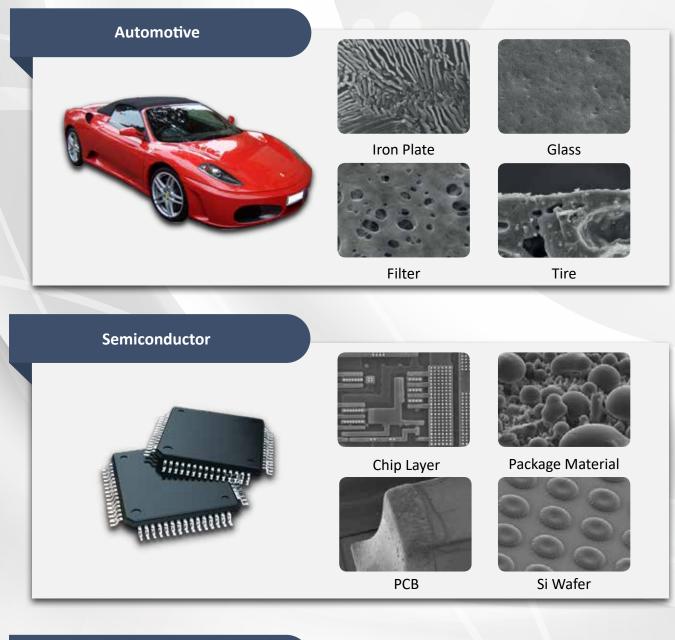
-SE Image of Film Surface



-BSE Image of Film Surface

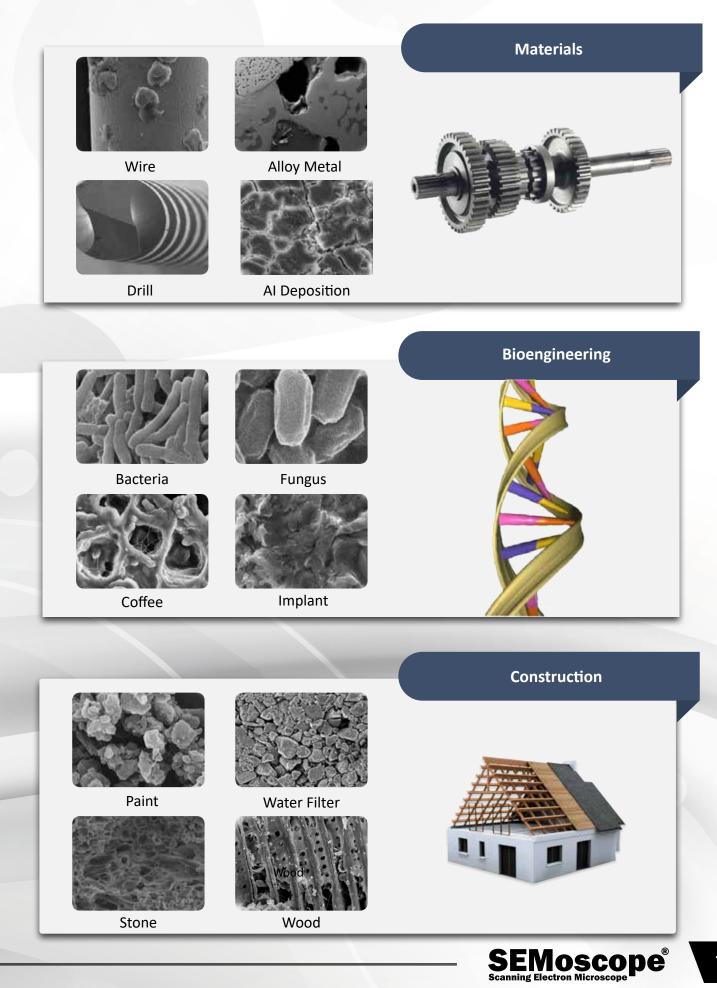


## Applications





## Applications



## Comparison Table

Items/Model	IEM - 11	IEM - 11+	IEM - 10	IEM - 10+	
Resolution SE	5.0nm a	5.0nm at 30kV		20nm at 30kV	
Magnification	x20 ~ x150,000		x20 ~ x100,000		
Efficient Magnification	~ x80,000		~ x50,000		
Acceleration Voltage	1 ~ 30 kV				
Vacuum Mode	High Vacuum				
Vacuum Mode	Low Vacuum	Low Vacuum (Optional)		-	
EDS	External (Optional)	Integrated (Standard)	External (Optional)	Integrated (Standard)	
Maximum Specimen Size		60 (mm) - 2,36 (inch) in diameter			
Stage	3-Axes Motorized				
X	0~35(mm) - 1,37(inch)				
Y	0~35(mm) - 1,37(inch)				
т	0~45 (mm) - 1,77(inch)				
Z	5~50(mm) (Manual)				
R	360° (Raster)				
Observation Area	40(mm) - 1,57(inch) in diameter				
Maximum Height	45(mm) - 1,77(inch)				
Electron Gun	Pre-centered Cartridge				
Source	Tungsten				
Data	SE				
Detector	BSE(Standard) BSE(Optional)			Optional)	

Comparison Table

	Mouse			
Control	Keyboard			
	Joys	stick		-
	Auto Focus			
Auto Image Adjustment	Auto Brightness & Contrast			
	Auto Filament			
	Auto Start			
	Navigation View		Measurement Tool	
	Special Multi Holder		Remote Control	
	Signal Mixing (SE+BSE)			
	Dual Display(SE/BSE)			
Special Features	BSE(Compo,Topo)			
	Line Profile			-
	Image Process			
	Measurement Tool			
	Remote Control			
Options	EDS	-	EDS	
		-	В	SED
	Low Vacuum			
	Cool Stage			





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